

**Search Notes**

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Examiner

Hai C. Pham

Applicant(s)/Patent under  
Reexamination

YAMAKAWA, HIROMITSU

Art Unit

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**SEARCHED**

Class	Subclass	Date	Examiner
347	241-244, 256-258	5/28/2006	HP
359	204-205	5/28/2006	HP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Text Search	5/28/2006	HP